Application/Control No.	Applicant(s)/Patent under Reexamination	
10/693,058	CHO ET AL.	
Examiner	Art Unit	
 Thi Q. Le	2613	

SEARCHED					
Class	Subclass	Date	Examiner		
398	25	12/4/2007	TL		
			-		
_					
			·		
_					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
398	25	12/4/2007	TL		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST image and keyword search in US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT and IBM_TDB (see EAST search history attached)	12/4/2007	TL		
NPL Search (IEEE xplore, INSPEC, SPIE etc.)	12/4/2007	TL		
LI SHI K	12/4/2007	TL		
	,			